Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/709,890	LIN ET AL.	
Examiner	**Art Unit**	
Wen-Ying P. Chen	2871	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Review previously cited references	2/22/2006	WPC